Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/695,061	KIM ET AL.
Examiner	Art Unit
Matthew Landau	2815

SEARCHED					
Class	Subclass	Date	Examiner		
257	377, Eal.507	1/12/05	m		
438	586	L	4		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
(printout included)	11/12/05	mch		
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